

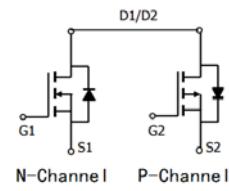
## Features

- N+P Channel
- Enhancement mode
- Very low on-resistance
- Fast Switching
- Pb-free lead plating; RoHS compliant

$V_{DS}$	30	-30	V
$R_{DS(on),TYP} @ V_{GS}=\pm 10\text{ V}$	10	24	$\text{m}\Omega$
$R_{DS(on),TYP} @ V_{GS}=\pm 4.5\text{ V}$	13	40	$\text{m}\Omega$
$I_D$	30	-22	A

**TO-252-4L**


Part ID	Package Type	Marking	Tape and reel information
VSD010C03MC	TO-252-4L	010C03MC	2500pcs/Reel



## Absolute Maximum ratings, at $T_j=25\text{ }^\circ\text{C}$ , unless otherwise specified

Symbol	Parameter	Rating		Unit	
		NMOS	PMOS		
$V_{GS}$	Gate-Source Voltage	$\pm 20$	$\pm 20$	V	
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	30	-30	V	
$T_{STG} T_J$	Storage and operating temperature range	$-55 \text{ to } 175$		$^\circ\text{C}$	
$I_S$	Diode Continuous Forward Current	$T_C = 25\text{ }^\circ\text{C}$	30	-22	A

## Mounted on Large Heat Sink

$I_{DM}$	Pulse Drain Current Tested②	$T_C = 25\text{ }^\circ\text{C}$	120	-88	A
$I_D$	Continuous Drain Current	$T_C = 25\text{ }^\circ\text{C}$	30	-22	A
		$T_C = 100\text{ }^\circ\text{C}$	19	-14	
$P_D$	Power dissipation for Dual Operation		$T_C = 25\text{ }^\circ\text{C}$	25	W
$R_{\theta JC}$	Thermal Resistance-Junction to Case		6	$^\circ\text{C}/\text{W}$	
$R_{\theta JA}$	Thermal Resistance Junction-Ambient		45	$^\circ\text{C}/\text{W}$	

## Drain-Source Avalanche Ratings

EAS	Avalanche Energy, Single Pulsed	56③	72④	mJ
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### N-Channel Electrical Characteristics

Symbol	Parameter	Condition	Min	Typ	Max	Unit
<b>Static Electrical Characteristics @ <math>T_j = 25^\circ\text{C}</math> (unless otherwise stated)</b>						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	30	--	--	V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}}=30\text{V}, V_{\text{GS}}=0\text{V}$	--	--	1	$\mu\text{A}$
	Zero Gate Voltage Drain Current( $T_j = 125^\circ\text{C}$ )	$V_{\text{DS}}=30\text{V}, V_{\text{GS}}=0\text{V}$	--	--	100	$\mu\text{A}$
$I_{\text{GSS}}$	Gate-Body Leakage Current	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	--	--	$\pm 100$	nA
$V_{\text{GS(TH)}}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	1.0	1.6	2.5	V
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance <sup>②</sup>	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=8\text{A}$	--	10	13	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=6\text{A}$	--	14	18	$\text{m}\Omega$

### Dynamic Electrical Characteristics @ $T_j = 25^\circ\text{C}$ (unless otherwise stated)

$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}}=25\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	--	880	--	pF
$C_{\text{oss}}$	Output Capacitance		--	110	--	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance		--	95	--	pF
$Q_g$	Total Gate Charge	$V_{\text{DS}}=15\text{V}, I_{\text{D}}=10\text{A}, V_{\text{GS}}=10\text{V}$	--	18	--	nC
$Q_{\text{gs}}$	Gate Source Charge		--	3.8	--	nC
$Q_{\text{gd}}$	Gate Drain Charge		--	4.5	--	nC

### Switching Characteristics

$t_{\text{d(on)}}$	Turn on Delay Time	$V_{\text{DD}}=15\text{V}, I_{\text{D}}=3.5\text{A}, R_{\text{G}}=3.3\Omega, V_{\text{GS}}=10\text{V}$	--	7	--	nS
$t_r$	Turn on Rise Time		--	14	--	nS
$t_{\text{d(off)}}$	Turn Off Delay Time		-	22	--	nS
$t_f$	Turn Off Fall Time		--	8	--	nS

### Source Drain Diode Characteristics@ $T_j = 25^\circ\text{C}$ (unless otherwise stated)

$V_{\text{SD}}$	Forward on voltage	$I_{\text{SD}}=10\text{A}, V_{\text{GS}}=0\text{V}$	--	0.83	1.2	V
$t_{\text{rr}}$	Reverse Recovery Time	$T_j=25^\circ\text{C}, I_{\text{SD}}=5\text{A}, V_{\text{GS}}=0\text{V}$	--	13	--	nS
$Q_{\text{rr}}$	Reverse Recovery Charge		--	11	--	nC



### P-Channel Electrical Characteristics

Symbol	Parameter	Condition	Min	Typ	Max	Unit
<b>Static Electrical Characteristics @ <math>T_j = 25^\circ\text{C}</math> (unless otherwise stated)</b>						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=-250\mu\text{A}$	-30	--	--	V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}}=-30\text{V}, V_{\text{GS}}=0\text{V}$	--	--	-1	$\mu\text{A}$
	Zero Gate Voltage Drain Current( $T_j = 125^\circ\text{C}$ )	$V_{\text{DS}}=-30\text{V}, V_{\text{GS}}=0\text{V}$	--	--	-100	$\mu\text{A}$
$I_{\text{GSS}}$	Gate-Body Leakage Current	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	--	--	$\pm 100$	nA
$V_{\text{GS}(\text{TH})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=-250\mu\text{A}$	-1.0	-2.0	-2.5	V
$R_{\text{DS}(\text{ON})}$	Drain-Source On-State Resistance <sup>②</sup>	$V_{\text{GS}}=-10\text{V}, I_{\text{D}}=-6\text{A}$	--	24	30	$\text{m}\Omega$
		$V_{\text{GS}}=-4.5\text{V}, I_{\text{D}}=-5\text{A}$	--	40	50	$\text{m}\Omega$
<b>Dynamic Electrical Characteristics @ <math>T_j = 25^\circ\text{C}</math> (unless otherwise stated)</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}}=-25\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	--	950	--	pF
$C_{\text{oss}}$	Output Capacitance		--	115	--	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance		--	105	--	pF
$Q_g$	Total Gate Charge	$V_{\text{DS}}=-15\text{V}, I_{\text{D}}=-5\text{A}, V_{\text{GS}}=-10\text{V}$	--	18	--	nC
$Q_{\text{gs}}$	Gate Source Charge		--	5	--	nC
$Q_{\text{gd}}$	Gate Drain Charge		--	4.2	--	nC
<b>Switching Characteristics</b>						
$t_{\text{d}(\text{on})}$	Turn on Delay Time	$V_{\text{DD}}=-15\text{V}, I_{\text{D}}=-5\text{A}, R_{\text{G}}=3.3\Omega, V_{\text{GS}}=-10\text{V}$	--	11	--	ns
$t_r$	Turn on Rise Time		--	39	--	ns
$t_{\text{d}(\text{off})}$	Turn Off Delay Time		-	26	--	ns
$t_f$	Turn Off Fall Time		--	30	--	ns
<b>Source Drain Diode Characteristics@ <math>T_j = 25^\circ\text{C}</math> (unless otherwise stated)</b>						
$V_{\text{SD}}$	Forward on voltage	$I_{\text{SD}}=-6\text{A}, V_{\text{GS}}=0\text{V}$	--	-0.85	-1.2	V
$t_{\text{rr}}$	Reverse Recovery Time	$T_j=25^\circ\text{C}, I_{\text{SD}}=-5\text{A}, V_{\text{GS}}=0\text{V}$ $dI/dt=-2000\text{A}/\mu\text{s}$	--	31	--	nS
$Q_{\text{rr}}$	Reverse Recovery Charge		--	19	--	nC

Notes:

① Repetitive rating; pulse width limited by max. junction temperature.

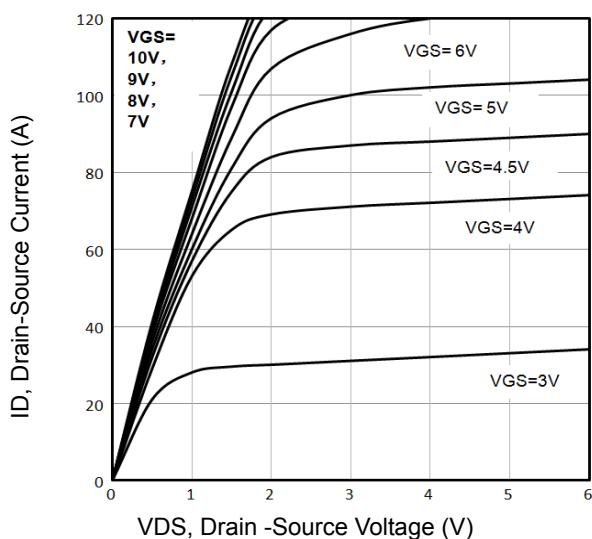
② Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$

③ Limited by  $T_{\text{Jmax}}$ , starting  $T_j = 25^\circ\text{C}$ ,  $L = 0.5\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{\text{AS}} = 15\text{A}$ ,  $V_{\text{GS}} = 10\text{V}$ . Part not recommended for use above this value

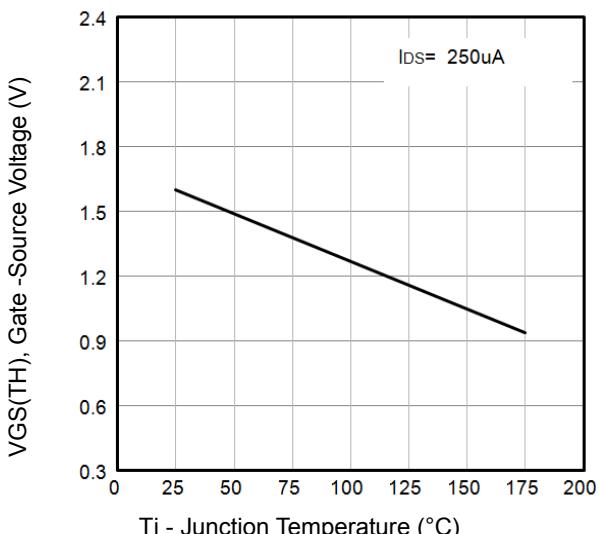
④ Limited by  $T_{\text{Jmax}}$ , starting  $T_j = 25^\circ\text{C}$ ,  $L = 0.5\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{\text{AS}} = -17\text{A}$ ,  $V_{\text{GS}} = -10\text{V}$ . Part not recommended for use above this value



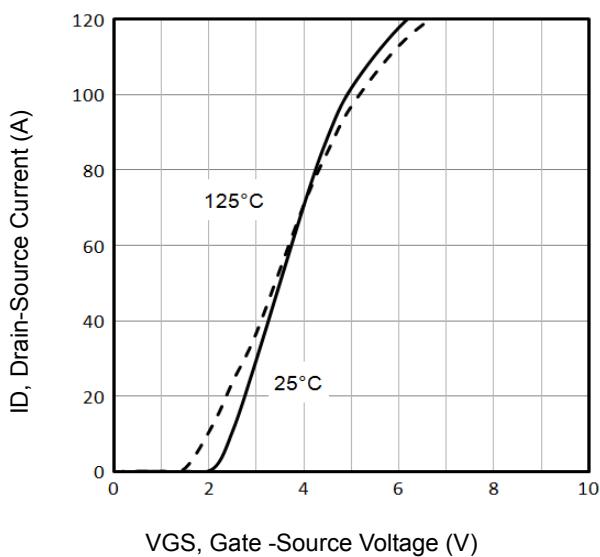
### N-Channel Typical Characteristics



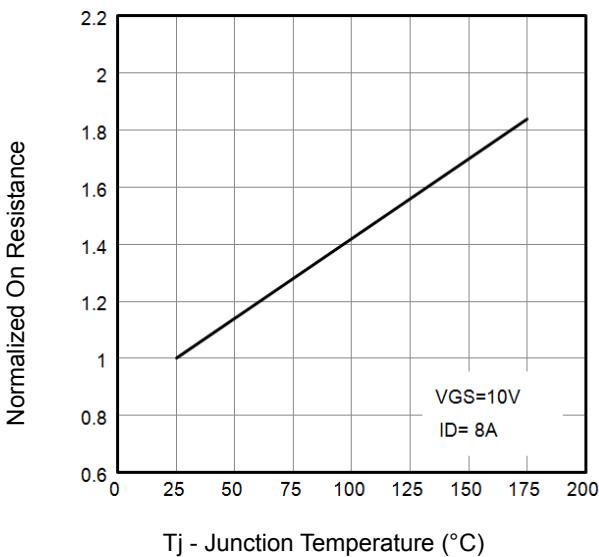
**Fig1.** Typical Output Characteristics



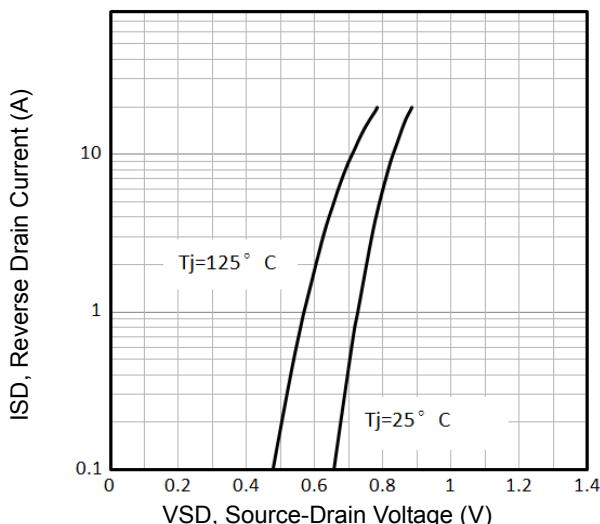
**Fig2.**  $V_{GS(TH)}$  Gate -Source Voltage Vs. $T_j$



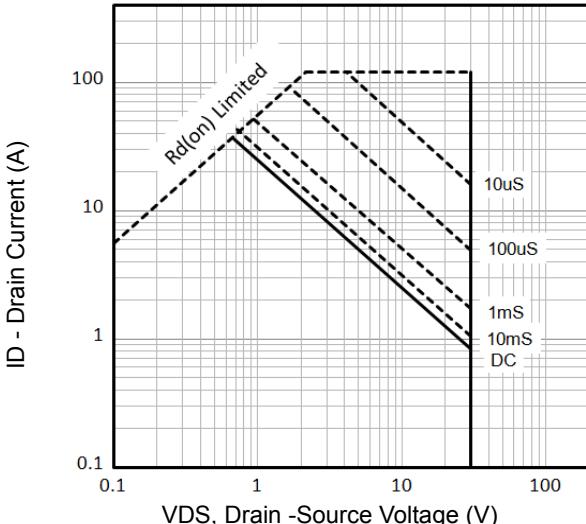
**Fig3.** Typical Transfer Characteristics



**Fig4.** Normalized On-Resistance Vs.  $T_j$



**Fig5.** Typical Source-Drain Diode Forward Voltage



**Fig6.** Maximum Safe Operating Area



### N-Channel Typical Characteristics

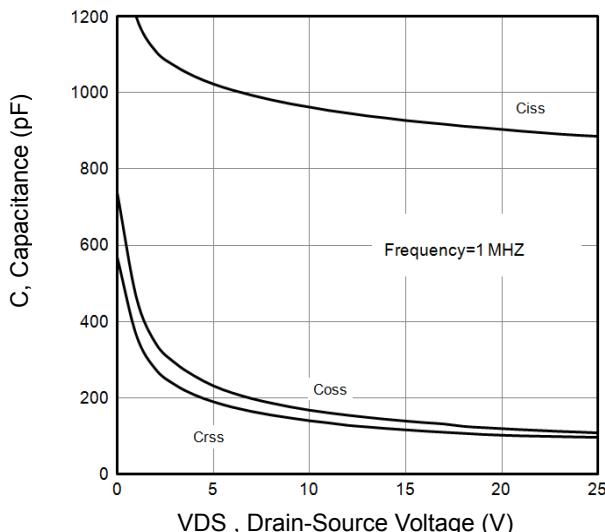


Fig 7. Typical Capacitance Vs. Drain-Source Voltage

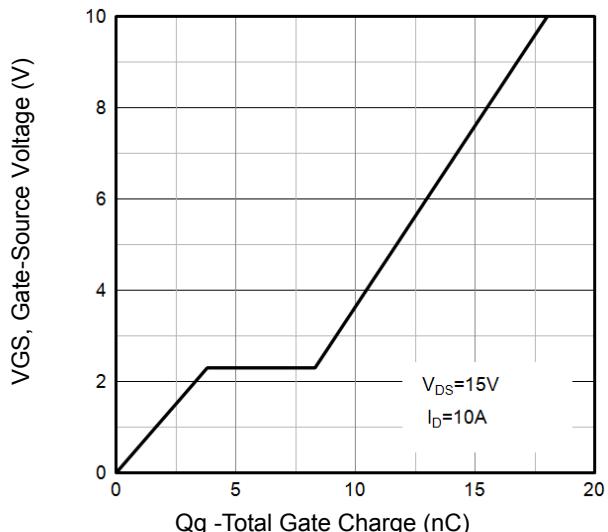


Fig 8. Typical Gate Charge Vs. Gate-Source Voltage

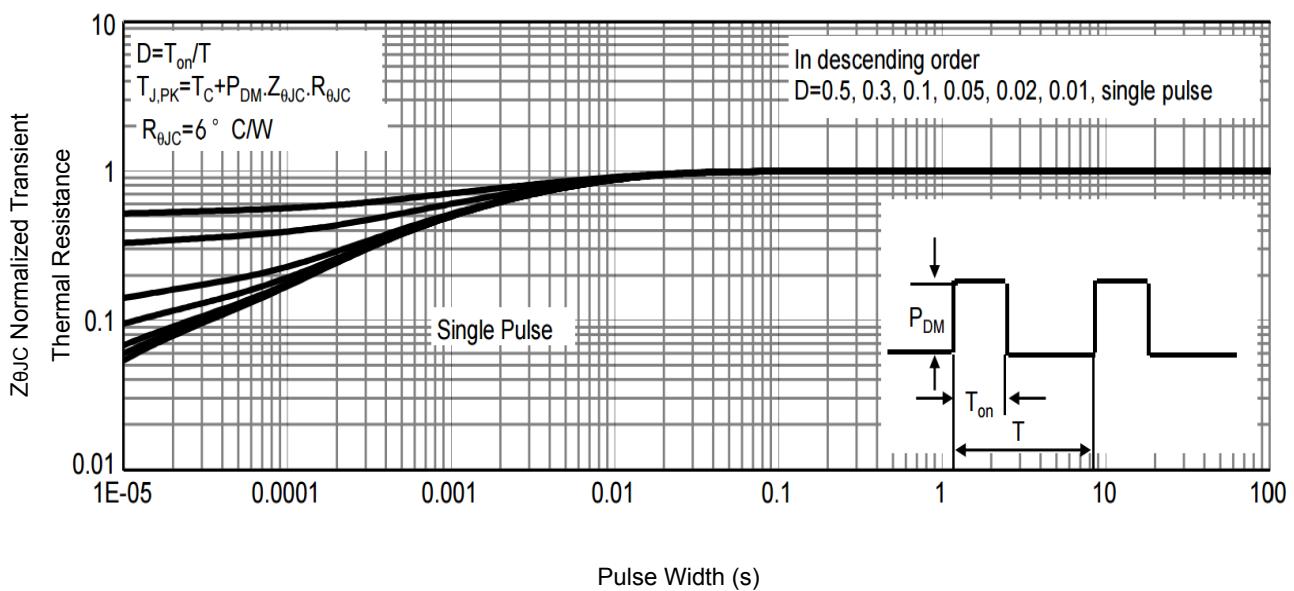


Fig 9 .Normalized Maximum Transient Thermal Impedance

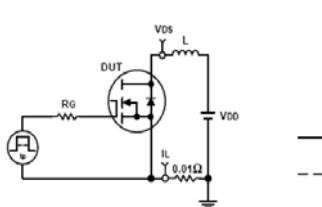


Fig 10. Unclamped Inductive Test Circuit and waveforms

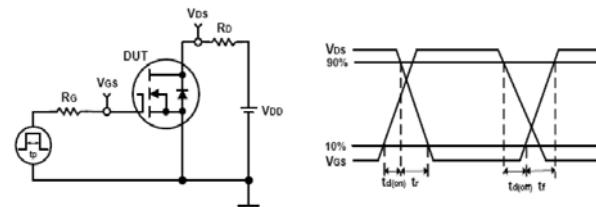


Fig 11. Switching Time Test Circuit and waveforms



### P-Channel Typical Characteristics

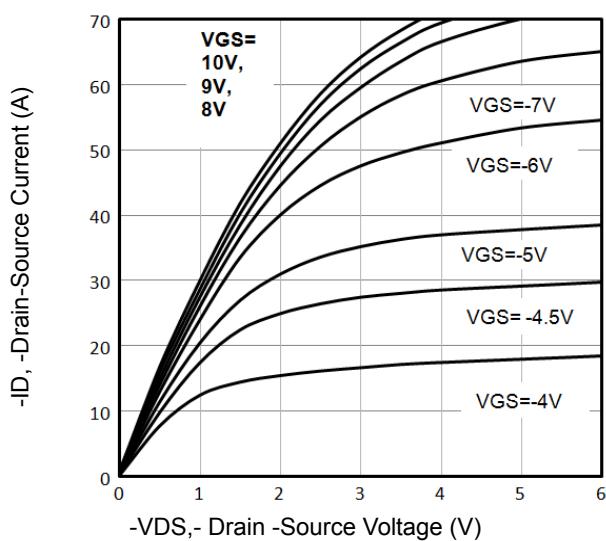


Fig1. Typical Output Characteristics

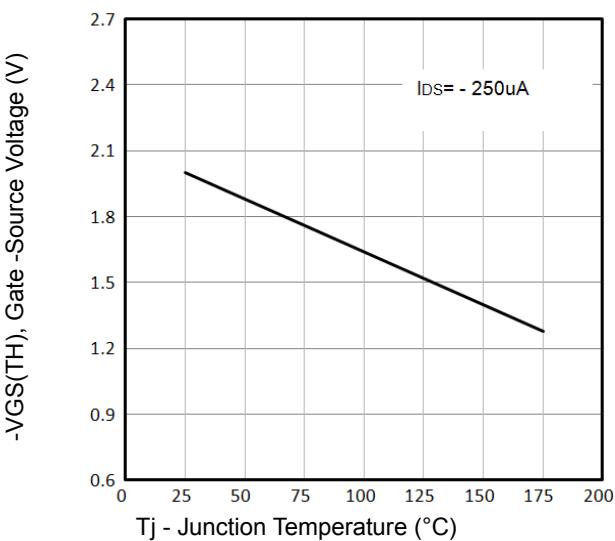


Fig2.  $V_{GS(TH)}$  Gate -Source Voltage Vs.  $T_j$

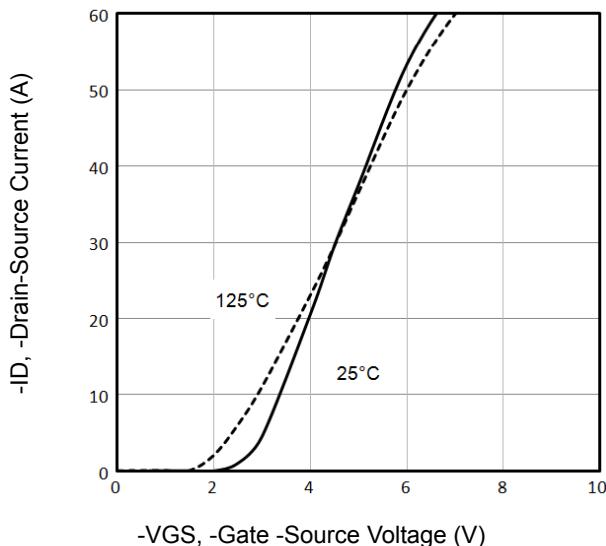


Fig3. Typical Transfer Characteristics

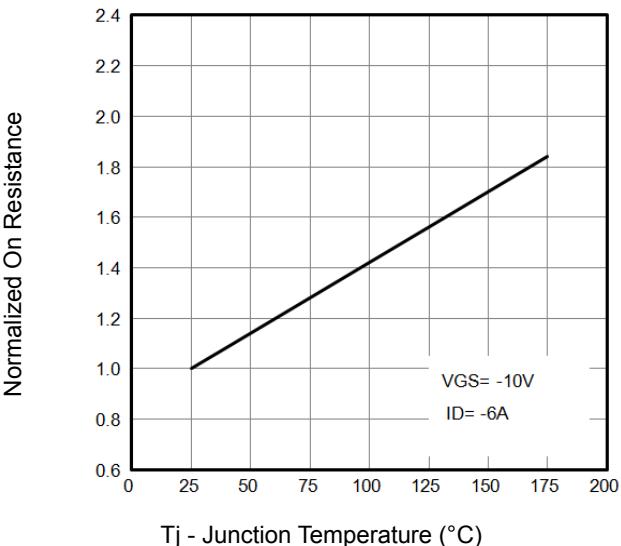


Fig4. Normalized On-Resistance Vs.  $T_j$

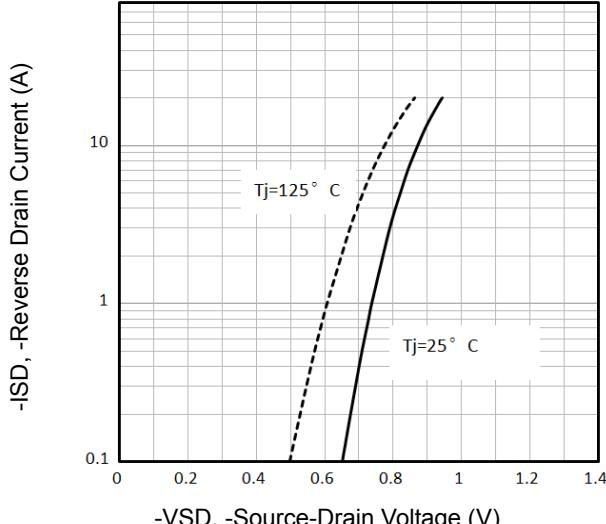


Fig5. Typical Source-Drain Diode Forward Voltage

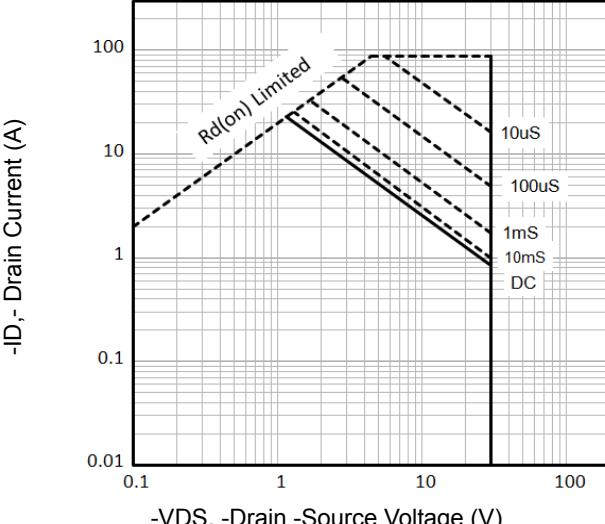


Fig6. Maximum Safe Operating Area



### P-Channel Typical Characteristics

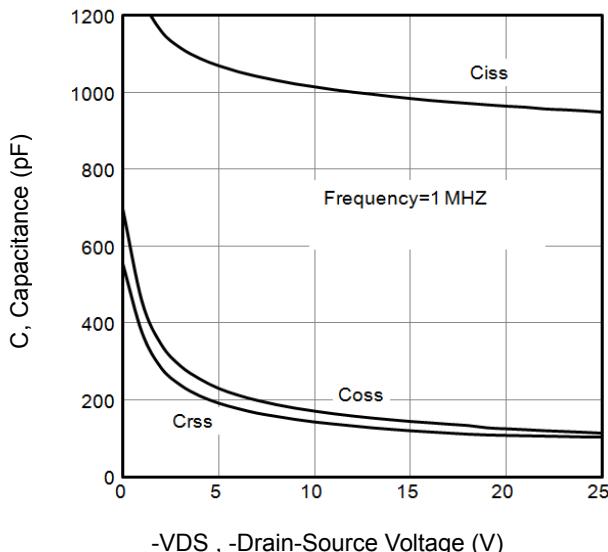


Fig7. Typical Capacitance Vs.Drain-Source Voltage

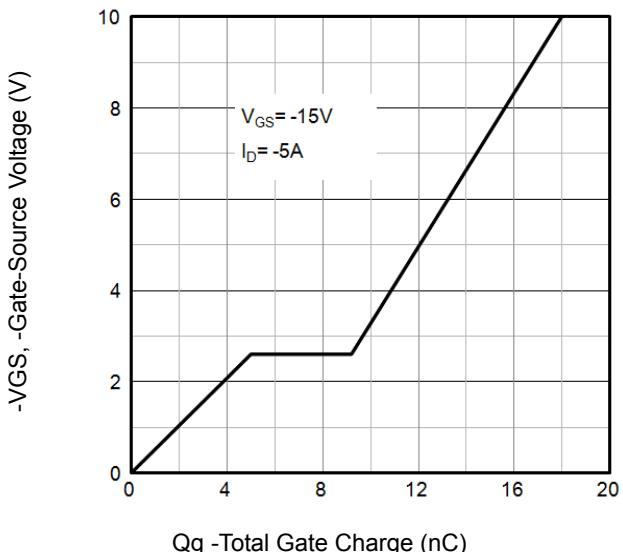


Fig8. Typical Gate Charge Vs.Gate-Source Voltage

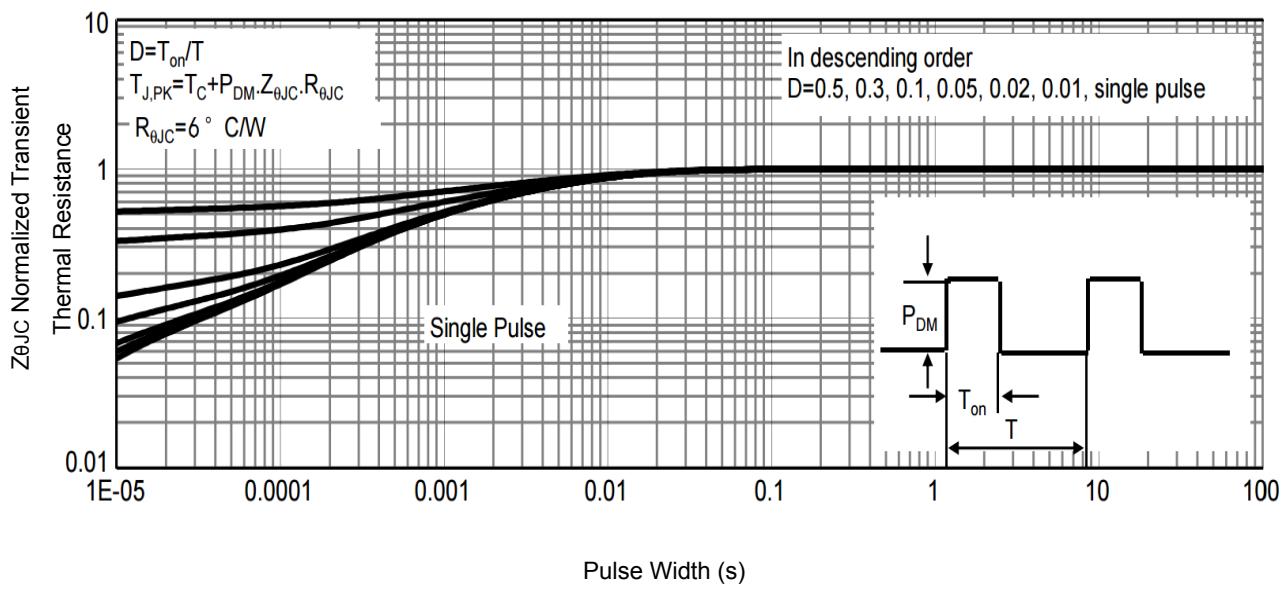


Fig9. Normalized Maximum Transient Thermal Impedance

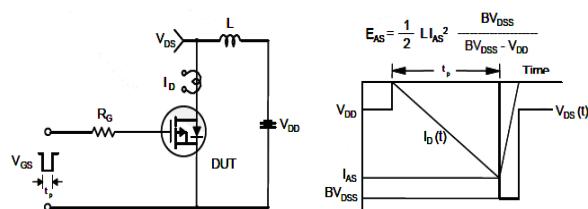


Fig10. Unclamped Inductive Test Circuit and Waveforms

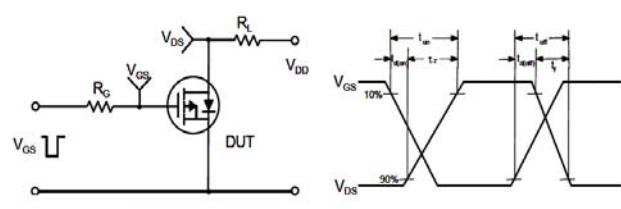
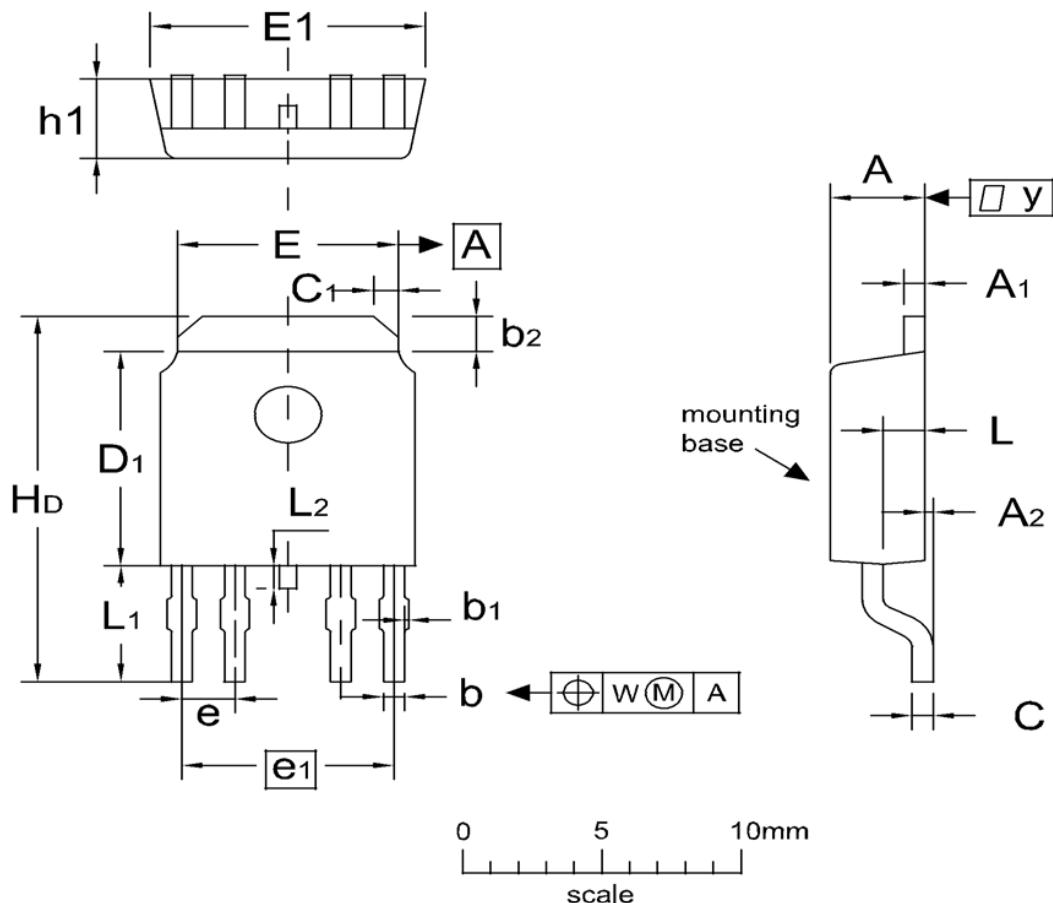


Fig11. Switching Time Test Circuit and waveforms



## TO-252-4L Package Outline Data



### DIMENSIONS (unit : mm)

Symbol	Min	Typ	Max	Symbol	Min	Typ	Max
A	2.1	2.3	2.5	A <sub>1</sub>	0.4	0.5	0.6
A <sub>2</sub>	--	--	0.3	b	0.4	0.5	0.6
b <sub>1</sub>	--	--	0.1	b <sub>2</sub>	0.8	1.0	1.2
C	0.4	0.5	0.6	C <sub>1</sub>	0.4	0.6	0.8
D <sub>1</sub>	5.7	6.1	6.5	E	5.0	5.3	5.6
E <sub>1</sub>	6.3	6.6	6.9	e	--	1.27	--
e <sub>1</sub>	--	5.08	--	H <sub>D</sub>	9.6	10.0	10.4
h <sub>1</sub>	2.1	2.3	2.5	L	0.80	1.0	1.2
L <sub>1</sub>	2.6	2.9	3.2	L <sub>2</sub>	0.35	0.65	0.95

## Customer Service

### Sales and Service:

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